Substitute for form 1449A/PTO INFORMATION DISCLOSURE STATEMENT BY APPLICANT (use as many sheets as necessary)				Complete if Known		
			CHDE	Application Number		
			SURE	Filing Date		
			CANT	First Named Inventor	Ebrahim Andideh	
				Art Unit	2824 2818	
				Examiner Name	Owens, Beth E.	
Sheet	1	of	3	Attorney Docket Number	42P10698D	

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Examiner Initials*	Cite No.'	Document Number Number - Kind Code ² (if known)	Publication Date or Issue Date MM-DD-YYYY	Name of Patentee or Applicant of Cited Document	Pages, Columns, Lines, Where Relevant Passages or Relevant Figures Appear			
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TH		EP 1 077 477 A1	02-21-2001	Applied Materials, Inc.					
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77		WO 99/38202	07-29-1999	Trikon Equipments Limited		1			
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Substitute for form 1448A/PTO INFORMATION DISCLOSURE				Co	Complete if Known		
			CUDE	Application Number			
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STAT	STATEMENT BY APPLICANT			First Named Inventor	Ebrahim Andideh		
				Art Unit	2824 28 (8		
				Examiner Name	Owens, Beth E.		
Sheet	2	of	3	Attorney Docket Number	42P10698D		

OTHER ART - NON PATENT LITERATURE DOCUMENTS							
Examiner Initials*	Cite No.1	Include name of the author (in CAPITAL LETTERS), title of the article (when appropriate), title of the item (book, magazine, journal, serial, symposium, catalog, etc.), date, page(s), volume-issue number(s), publisher, city and/or country where published.	T²				
TH		Search Report for PCT/US 02/31525 mailed January 22, 2003, 5 pages.					
THP		WEBER, D., ET AL., Impact of substituting SiO, ILD by low k materials into A1Cu RIE metallization, Infineon Technologies AG, Konigsbruckerstrasse 180, D-01099 Dresden Germany, * current address: Infineon Technologies, Inc, IBM Semiconductor Research and					
Mar		Development Center, Hopewell Junction, NY 12533, USA, 3 pages, no date.					
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Substitute for form 1449A/PTO INFORMATION DISCLOSURE STATEMENT BY APPLICANT				Complete If Known		
				Application Number		
			SUKE	Filing Date		
			CANT	First Named Inventor	Ebrahim Andideh	
	(use as many sheets as necessary)			Art Unit	2824-2818	
				Examiner Name	Owens, Beth E.	
Sheet	3	of	3	Attorney Docket Number	42P10698D	

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Examiner Initials*	Cite No.'	Document Number Number - Kind Code ² (if known)	Publication Date MM-DD-YYYY	Name of Patentee or Applicant of Cited Document	Pages, Columns, Lines, Where Relevant Passages or Relevant Figures Appear				
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Substitute for Form 1449	9/PTO		Complete i	f Kn wn
INFOR	RMATION DISCLOSUR	Application Number	10/654,109	
			Filing Date	September 2, 2003
O', STALE	EMENT BY APPLICAN	T	First Named Inventor:	Ebrahim Andideh
	(use as many sheets as necessary)		Art Unit	2812 2818
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Sheet	of 1		Attorney Docket Number	42P10698D
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Examiner Cite No. ' Initials*	Document Number Number-Kind Code ² (If known)	Publication Date MM-DD-YYYY	Name of Patentee or Applicant of Cited Document	Pages, Columns, Lines, Where Relevant Passages or Relevant Figures Appear
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